



<p>Searched</p> 	<p>Application/Control No.</p> <p>10391599</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>KAWAI ET AL.</p>
	<p>Examiner</p> <p>Kaplan, Hal I</p>	<p>Art Unit</p> <p>2836</p>

Class	SubClass	Date	Examiner
180	277	06/13/2006	HK
180	279	06/13/2006	HK

EAST

(US-PGPUB,USPAT,USOCR,E
PO,JPO,DERWENT,IBM_TDB

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Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10391599	KAWAI ET AL.
	Examiner Kaplan, Hal I	Art Unit 2836

Notes	Date	Examiner
180/271,277,279,282 (consulted Faye Fleming)	06/13/2006	HK
307/9.1,10.1 (consulted Robert DeBeradinis)	06/13/2006	HK
EAST (US-PGPUB,USPAT,USOCR,EPO,JPO,DERWENT,IBM_TDB) - See Search History Printout	06/13/2006	HK
180/271,282 (cursory)	06/13/2006	HK
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